

MAXIMUM RATINGS

Rating	Symbol	P2N 2907	P2N 2907A	Unit
Collector-Emitter Voltage	V_{CEO}	40	60	Vdc
Collector-Base Voltage	V_{CBO}	60	—	Vdc
Emitter-Base Voltage	V_{EBO}	5.0	—	Vdc
Collector Current - Continuous	I_C	600	—	mAdc
Total Device Dissipation $T_A = 25^\circ\text{C}$ Derate above 25°C	P_D	625	—	mW
		5.0	—	$\text{mW}/^\circ\text{C}$
Total Device Dissipation $T_C = 25^\circ\text{C}$ Derate above 25°C	P_D	1.5	—	Watts
		12	—	$\text{mW}/^\circ\text{C}$
Operating and Storage Junction Temperature Range	T_J, T_{Stg}	-55 to +150	—	°C

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case	$R_{\theta JC}$	83.3	°C/W
Thermal Resistance, Junction to Ambient	$R_{\theta JA}$	200	°C/W

**P2N2907
P2N2907A****CASE 29-02, STYLE 17
TO-92 (TO-226AA)****AMPLIFIER TRANSISTORS**

PNP SILICON

Refer to MPS2907 for graphs.

ELECTRICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$ unless otherwise noted.)

Characteristic	Symbol	Min	Max	Unit
OFF CHARACTERISTICS				
Collector-Emitter Breakdown Voltage (1) ($I_C = 10 \text{ mA}\text{dc}, I_B = 0$)	$V_{(BR)CEO}$ P2N2907 P2N2907A	40 60	—	Vdc
Collector-Base Breakdown Voltage ($I_C = 10 \mu\text{A}\text{dc}, I_E = 0$)	$V_{(BR)CBO}$	60	—	Vdc
Emitter-Base Breakdown Voltage ($I_E = 10 \mu\text{A}\text{dc}, I_C = 0$)	$V_{(BR)EBO}$	5.0	—	Vdc
Collector Cutoff Current ($V_{CE} = 30 \text{ Vdc}, V_{EB(\text{off})} = 0.5 \text{ Vdc}$)	I_{CEX}	—	50	nAdc
Collector Cutoff Current ($V_{CB} = 50 \text{ Vdc}, I_E = 0$)	I_{CBO} P2N2907 P2N2907A	—	0.020 0.010	μAdc
($V_{CB} = 50 \text{ Vdc}, I_E = 0, T_A = 125^\circ\text{C}$)		—	20 10	
Base Current ($V_{CE} = 30 \text{ Vdc}, V_{EB(\text{off})} = 0.5 \text{ Vdc}$)	I_B	—	50	nAdc

ON CHARACTERISTICS

DC Current Gain ($I_C = 0.1 \text{ mA}\text{dc}, V_{CE} = 10 \text{ Vdc}$)	P2N2907 P2N2907A	h_{FE}	35 75	— —
($I_C = 1.0 \text{ mA}\text{dc}, V_{CE} = 10 \text{ Vdc}$)	P2N2907 P2N2907A		50 100	— —
($I_C = 10 \text{ mA}\text{dc}, V_{CE} = 10 \text{ Vdc}$)	P2N2907 P2N2907A		75 100	— —
($I_C = 150 \text{ mA}\text{dc}, V_{CE} = 10 \text{ Vdc}$) (1)	P2N2907, P2N2907A		100	300
($I_C = 500 \text{ mA}\text{dc}, V_{CE} = 10 \text{ Vdc}$) (1)	P2N2907 P2N2907A		30 50	— —
Collector-Emitter Saturation Voltage (1) ($I_C = 150 \text{ mA}\text{dc}, I_B = 15 \text{ mA}\text{dc}$)	$V_{CE(\text{sat})}$	—	0.4	Vdc
($I_C = 500 \text{ mA}\text{dc}, I_B = 50 \text{ mA}\text{dc}$)		—	1.6	
Base-Emitter Saturation Voltage (1) ($I_C = 150 \text{ mA}\text{dc}, I_B = 15 \text{ mA}\text{dc}$)	$V_{BE(\text{sat})}$	—	1.3	Vdc
($I_C = 500 \text{ mA}\text{dc}, I_B = 50 \text{ mA}\text{dc}$)		—	2.6	

P2N2907, P2N2907A

ELECTRICAL CHARACTERISTICS (continued) ($T_A = 25^\circ\text{C}$ unless otherwise noted.)

Characteristic	Symbol	Min	Max	Unit
SMALL-SIGNAL CHARACTERISTICS				
Current-Gain – Bandwidth Product (1), (2) ($I_C = 50 \text{ mA DC}$, $V_{CE} = 20 \text{ V DC}$, $f = 100 \text{ MHz}$)	f_T	200	—	MHz
Output Capacitance ($V_{CB} = 10 \text{ V DC}$, $I_E = 0$, $f = 1.0 \text{ MHz}$)	C_{obo}	—	8.0	pF
Input Capacitance ($V_{BE} = 2.0 \text{ V DC}$, $I_C = 0$, $f = 1.0 \text{ MHz}$)	C_{ibo}	—	30	pF
SWITCHING CHARACTERISTICS				
Turn-On Time	t_{on}	—	50	ns
Delay Time	t_d	—	10	ns
Rise Time	t_r	—	40	ns
Turn-Off Time	t_{off}	—	110	ns
Storage Time	t_s	—	80	ns
Fall Time	t_f	—	30	ns

FIGURE 1 – DELAY AND RISE TIME TEST CIRCUIT

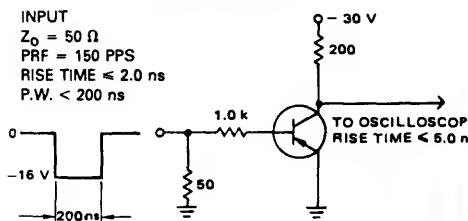


FIGURE 2 – STORAGE AND FALL TIME TEST CIRCUIT

